Errata IWRL6843/44 Device Silicon Errata Silicon Revisions ES1.0



Table of Contents

1 Introduction	2
2 Device Nomenclature	2
3 Device Markings	3
4 Advisory to Silicon Variant / Revision Map	5
5 Known Design Exceptions to Functional Specifications	6
6 Trademarks	9
Revision History	9



1 Introduction

This document describes the known exceptions to the functional and performance specifications to TI CMOS Radar Devices (IWRL684x)

2 Device Nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of Radar / mmWave sensor devices. Each of the Radar devices has one of the two prefixes: XIx or IWRLx (for example: **IWRL6844DBGANC**). These prefixes represent evolutionary stages of product development from engineering prototypes (XAL/XIL) through fully qualified production devices (IWRL).

Device development evolutionary flow:

- XIL Experimental device that is not necessarily representative of the final device's electrical specifications and may not use production assembly flow.
- **IWRL** Production version of the silicon die that is fully qualified.

XIL devices are shipped with the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

Texas Instruments recommends that these devices not to be used in any production system as their expected end –use failure rate is still undefined.



3 Device Markings

Figure 3-1 shows an example of the IWRL684x Radar Device's package symbolization.





This identifying number contains the following information:

- Line 1: TI Logo
- Line 1: Device Number
- Line 2: Safety Level and Security Grade
 - Q = Non-Functional Safety
 - B = ASIL-B capable
 - G = General
 - S = Secure
- Line 3: Lot Trace Code
 - YM = Year/Month Code
 - Z- Assembly Site Code



- LLL = Assembly Lot
- 9= Primary Site Code
- Line 4:
 - 795 = Device Identifier
 - ANC = Package Identifier
 - G1 = "Green" Package Build (must be underlined)



4 Advisory to Silicon Variant / Revision Map

Advisory	Advisory Title			
Number				
Analog / Millimeter Wave				
ANA #51	Continuous Wave Streaming CZ mode: Sudden jump in RX output codes every 20.97152 msec	х		
Digital Subsystem				
DIG #17	HWA CFAR CA engine is not working if dynamic clock gating is enabled	х		

Table 4-1. Advisory to Silicon Variant / Revision Map



5 Known Design Exceptions to Functional Specifications

Continuous Wave Streaming CZ mode: Sudden jump in RX output codes every ANA #51 20.97152 msec **Revision(s)** Affected IWRL684x ES1.0 **Details** On Continuous Wave Streaming CZ mode, the Rx data shows a sudden jump in output codes every 20.97152 milliseconds. This is not an issue in the Radar Functional mode when chirps are used. However, this issue will be seen when testing Rx chain in lab using continuous stream mode. Workaround In order to use Continuous stream (CW) mode for testing, it is recommended to start data capturing from the first sample itself to make sure the glitch occurs at deterministic samples. Please follow the below sequence to achieve this: Configure the LVDS (Low Voltage Differential Signaling) ٠ Arm the DCA1000 (Data capture card) Enable the continuous stream mode. The glitch will not be seen with this sequence. For example, if the user analyzes first

20ms of data or between 21 and 41ms.

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DIG #17	<i>HWA CFAR CA engine is not working if dynamic clock gating is enabled</i> WRL684x ES1.0		
Revision(s) Affected			
Details	Dynamic clock gating feature is added in IP for power savings. Idea is to enable clock to the FFT/CFAR-CA/CFAR-OS engine only when the respective engine is needed to be active based on the mode of operation. However, when CFAR CA engine is enabled and dynamic clock gating is set, the clock to one of the logic in the engine gets gated. Due to this, the data transfer to the logic internal to the CFAR-CA engine gets hampered. Hence, we do not get any valid data in the output of the CFAR CA engine.		
Workaround	Disable the dynamic clock gating feature when CFAR CA mode of operation is enabled.		



6 Trademarks

All trademarks are the property of their respective owners.

Revision History

DATE	REVISION	NOTES
December 2024	*	1.0

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